

<b>Notice of References Cited</b>	Application/Control No. 10/787,257	Applicant(s)/Patent Under Reexamination KEIDEL ET AL.	
	Examiner Essama Omgba	Art Unit 3726	Page 1 of 3

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	B	US-2005/0006010 A1	01-2005	Benedictus et al.	148/552
	C	US-2005/0058568 A1	03-2005	Boselli et al.	420/531
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<b>Notice of References Cited</b>	Application/Control No. 10/787,257	Applicant(s)/Patent Under Reexamination KEIDEL ET AL.	
	Examiner Essama Omgba	Art Unit 3726	Page 2 of 3

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	E	US-5,312,498	05-1994	Anderson, Kevin R.	148/695
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	Examiner Essama Omgba	Art Unit 3726	Page 3 of 3

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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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